

Presentation Abstract

Presentation Title	Artifact Mapping Tool - Overview, Usage and Lessons Learned
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Presentation Abstract	<p>The ability to trace between various software lifecycle artifacts and the analysis of those artifacts is a cornerstone of the work performed by IV&V analysts. The Artifact Mapping Tool (AMT) being produced by the IV&V SWAT team attempts to fulfill a simple vision; provide the ability to map (trace/associate) an item with any other item regardless of the source of the item's information. While the vision is simple the implementation is a bit more complex. This session provides an overview of the mapping concept, how it is being utilized and can be utilized, and some of the lessons learned in its implementation.</p>